

# 2Gb DDR3L SDRAM

Lead-Free&Halogen-Free (RoHS Compliant) H5TC2G83GFR-xxA H5TC2G83GFR-xxI H5TC2G83GFR-xxL H5TC2G83GFR-xxJ H5TC2G63GFR-xxA H5TC2G63GFR-xxL H5TC2G63GFR-xxJ

\* SK Hynix reserves the right to change products or specifications without notice.



# **Revision History**

Revision No.	History	Draft Date	Remark
0.1	Preliminary version release	Mar. 2015	Preliminary
1.0	IDD update	June. 2015	Page 25
1.1	Operating NOTE update	July. 2015	Page 4
1.2	IDD update	Oct. 2015	Page 25 - IDD3N x16
1.3	1.3 Typo Correct		Page 4



# Description

The H5TC2G83GFR-xxA(I,L,J) and H5TC2G63GFR-xxA(I,L,J) are a 2Gb low power Double Data Rate III (DDR3L) Synchronous DRAM, ideally suited for the main memory applications which requires large memory density, high bandwidth and low power operation at 1.35V. SK Hynix DDR3L SDRAM provides backward compatibility with the 1.5V DDR3 based environment without any changes. SK Hynix 2Gb DDR3L SDRAMs offer fully synchronous operations referenced to both rising and falling edges of the clock. While all addresses and control inputs are latched on the rising edges of the clock (falling edges of the clock), data, data strobes and write data masks inputs are sampled on both rising and falling edges of it. The data paths are internally pipelined and 8-bit prefetched to achieve very high bandwidth.

#### **Device Features and Ordering Information**

#### **FEATURES**

- VDD=VDDQ=1.35V + 0.100 / 0.067V
- Fully differential clock inputs (CK, CK) operation
- Differential Data Strobe (DQS, DQS)
- On chip DLL align DQ, DQS and DQS transition with CK transition
- DM masks write data-in at the both rising and falling edges of the data strobe
- All addresses and control inputs except data, data strobes and data masks latched on the rising edges of the clock
- Programmable CAS latency 6, 7, 8, 9, 10, 11, 12 and 13
  - supported
- Programmable additive latency 0, CL-1, and CL-2 supported
- Programmable CAS Write latency (CWL) = 5, 6, 7, 8 and 9
- Programmable burst length 4/8 with both nibble sequential and interleave mode

- BL switch on the fly
- 8banks
- Average Refresh Cycle (Tcase of 0 °C~95 °C)
   7.8 µs at 0°C ~ 85 °C
  - 3.9 µs at 85°C ~ 95 °C

Commerical Temperature (0°C ~ 95 °C) Industrial Temperature(-40°C ~ 95 °C)

- JEDEC standard 78ball FBGA(x8), 96ball FBGA(x16)
- Driver strength selected by EMRS
- Dynamic On Die Termination supported
- Asynchronous RESET pin supported
- ZQ calibration supported
- TDQS (Termination Data Strobe) supported (x8 only)
- Write Levelization supported
- 8 bit pre-fetch

#### \* This product in compliance with the RoHS directive.



#### ORDERING INFORMATION

Part No.	Configuration	Power Consumption	Temperature	Package
H5TC2G83GFR-*xxA		Normal Consumption	Commercial	
H5TC2G83GFR-*xxI	256M x 8	Normal consumption	Industrial	78ball FBGA
H5TC2G83GFR-*xxL	23000 x 0	Low Power Consumption		70ball 1 box
H5TC2G83GFR-*xxJ		(IDD6 Only)	Industrial	
H5TC2G63GFR-*xxA		Normal Consumption	Commercial	
H5TC2G63GFR-*xxI	128M x 16	Normal consumption	Industrial	96ball FBGA
H5TC2G63GFR-*xxL		Low Power Consumption	Commercial	900ali FDGA
H5TC2G63GFR-*xxJ	H5TC2G63GFR-*xxJ		Industrial	

\* xx means Speed Bin Grade

Speed Grade	Frequency [Mbps]										Remark
(Marking)	CL5	CL6	CL7	CL8	CL9	CL10	CL11	CL12	CL13	CL14	(CL-tRCD-tRP)
-G7*	667	800	1066	1066							DDR3L-1066 7-7-7
-H9*	667	800	1066	1066	1333	1333					DDR3L-1333 9-9-9
-PB*	667	800	1066	1066	1333	1333	1600				DDR3L-1600 11-11-11
-RD		800	1066	1066	1333	1333	1600		1866		DDR3L-1866 13-13-13

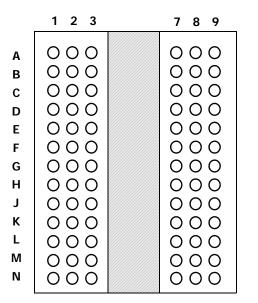
#### **OPERATING FREQUENCY**

\*Note1: -RD covers lower speed of -PB and -H9 and -G7.

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	1	2	3	4	5	6	7	8	9		
•	VCC	VDD	NG	1				VCC	VDD		•
Α	VSS	VDD	NC				NU/TDQS	VSS	VDD	,	Α
В	VSS	VSSQ	DQ0				DM/TDQS	VSSQ	VDDQ		В
С	VDDQ	DQ2	DQS				DQ1	DQ3	VSSQ		С
D	VSSQ	DQ6	DQS				VDD	VSS	VSSQ		D
Е	VREFDQ	VDDQ	DQ4				DQ7	DQ5	VDDQ		Е
F	NC	VSS	RAS				СК	VSS	NC		F
G	ODT	VDD	CAS				СК	VDD	CKE		G
н	NC	CS	WE				A10/AP	ZQ	NC		н
J	VSS	BA0	BA2				NC	VREFCA	VSS		J
к	VDD	A3	A0				A12/BC	BA1	VDD		к
L	VSS	A5	A2				A1	A4	VSS		L
М	VDD	A7	A9				A11	A6	VDD		М
Ν	VSS	RESET	A13				A14	A8	VSS		Ν
	1	2	3	4	5	6	7	8	9		

#### x8 Package Ball out (Top view): 78ball FBGA Package



#### (Top View: See the balls through the Package)

○ Populated ball

+ Ball not populated

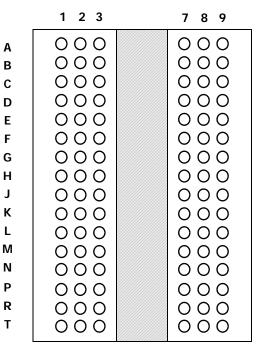


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	1	2	3	4	5	6	7	8	9		
				1						ſ	
Α	VDDQ	DQU5	DQU7				DQU4	VDDQ	VSS	ļ	Α
В	VSSQ	VDD	VSS				DQSU	DQU6	VSSQ		В
С	VDDQ	DQU3	DQU1				DQSU	DQU2	VDDQ		С
D	VSSQ	VDDQ	DMU				DQU0	VSSQ	VDD		D
Е	VSS	VSSQ	DQL0				DML	VSSQ	VDDQ		Е
F	VDDQ	DQL2	DQSL				DQL1	DQL3	VSSQ		F
G	VSSQ	DQL6	DQSL				VDD	VSS	VSSQ		G
н	VREFDQ	VDDQ	DQL4				DQL7	DQL5	VDDQ		Н
J	NC	VSS	RAS				СК	VSS	NC		J
к	ODT	VDD	CAS				СК	VDD	CKE		к
L	NC	CS	WE				A10/AP	ZQ	NC		L
м	VSS	BA0	BA2				NC	VREFCA	VSS		М
Ν	VDD	A3	A0				A12/BC	BA1	VDD		Ν
Р	VSS	A5	A2				A1	A4	VSS		Р
R	VDD	A7	A9				A11	A6	VDD		R
Т	VSS	RESET	A13				NC	A8	VSS	[	Т
				1							
	1	2	3	4	5	6	7	8	9		

# x16 Package Ball out (Top view): 96ball FBGA Package





#### (Top View: See the balls through the Package)

Populated ball

+ Ball not populated

#### **Pin Functional Description**

Symbol	Туре	Function
ск, <del>ск</del>	Input	Clock: CK and $\overline{CK}$ are differential clock inputs. All address and control input signals are sampled on the crossing of the positive edge of CK and negative edge of $\overline{CK}$ .
CKE, (CKE0), (CKE1)	Input	Clock Enable: CKE HIGH activates, and CKE Low deactivates, internal clock signals and device input buffers and output drivers. Taking CKE Low provides Precharge Power-Down and Self-Refresh operation (all banks idle), or Active Power-Down (row Active in any bank). CKE is asynchronous for Self-Refresh exit. After VREFCA and VREFDQ have become stable during the power on and initialization sequence, they must be maintained during all operations (including Self-Refresh). CKE must be maintained high throughout read and write accesses. Input buffers, excluding CK, CK, ODT and CKE, are disabled during power-down. Input buffers, excluding CKE, are disabled during Self-Refresh.
<u>CS</u> , ( <u>CS</u> 0), ( <u>CS1), (CS2),</u> ( <u>CS3</u> )	Input	Chip Select: All commands are masked when $\overline{CS}$ is registered HIGH. $\overline{CS}$ provides for external Rank selection on systems with multiple Ranks. $\overline{CS}$ is considered part of the command code.



Symbol	Туре	Function
ODT, (ODT0), (ODT1)	Input	On Die Termination: ODT (registered HIGH) enables termination resistance internal to the DDR3L SDRAM. When enabled, ODT is only applied to each DQ, DQS, DQS and DM/TDQS, NU/TDQS (When TDQS is enabled via Mode Register A11=1 in MR1) signal for x4/x8 configurations. For x16 configuration, ODT is applied to each DQ, DQSU, DQSU, DQSL, DQSL, DQSL, DMU, and DML signal. The ODT pin will be ignored if MR1 is programmed to disable ODT.
RAS. CAS. WE	Input	Command Inputs: $\overline{RAS}$ , $\overline{CAS}$ and $\overline{WE}$ (along with $\overline{CS}$ ) define the command being entered.
DM, (DMU), (DML)	Input	Input Data Mask: DM is an input mask signal for write data. Input data is masked when DM is sampled HIGH coincident with that input data during a Write access. DM is sampled on both edges of DQS. For x8 device, the function of DM or TDQS/TDQS is enabled by Mode Register A11 setting in MR1.
BA0 - BA2	Input	Bank Address Inputs: BA0 - BA2 define to which bank an Active, Read, Write or Precharge command is being applied. Bank address also determines if the mode register or extended mode register is to be accessed during a MRS cycle.
A0 - A15	Input	Address Inputs: Provide the row address for Active commands and the column address for Read/Write commands to select one location out of the memory array in the respective bank. (A10/AP and A12/BC have additional functions, see below). The address inputs also provide the op-code during Mode Register Set commands.
A10 / AP	Input	Auto-precharge: A10 is sampled during Read/Write commands to determine whether Autoprecharge should be performed to the accessed bank after the Read/Write operation. (HIGH: Autoprecharge; LOW: no Autoprecharge).A10 is sampled during a Precharge command to determine whether the Precharge applies to one bank (A10 LOW) or all banks (A10 HIGH). If only one bank is to be precharged, the bank is selected by bank addresses.
A12 / BC	Input	Burst Chop: A12 / BC is sampled during Read and Write commands to determine if burst chop (on-the-fly) will be performed. (HIGH, no burst chop; LOW: burst chopped). See command truth table for details.
RESET	Input	Active Low Asynchronous Reset: Reset is active when $\overrightarrow{\text{RESET}}$ is LOW, and inactive when $\overrightarrow{\text{RESET}}$ is HIGH. $\overrightarrow{\text{RESET}}$ must be HIGH during normal operation. $\overrightarrow{\text{RESET}}$ is a CMOS rail-to-rail signal with DC high and low at 80% and 20% of V <sub>DD</sub> , i.e. 1.20V for DC high and 0.30V for DC low.
DQ	Input / Output	Data Input/ Output: Bi-directional data bus.
DQU, <u>DQL</u> , DQS, <u>DQS,</u> DQSU, <u>DQSU,</u> DQSL, <u>DQSL</u>	Input / Output	Data Strobe: output with read data, input with write data. Edge-aligned with read data, centered in write data. The data strobe DQS, DQSL, and DQSU are paired with differential signals DQS, DQSL, and DQSU, respectively, to provide differential pair signaling to the system during reads and writes. DDR3L SDRAM supports differential data strobe only and does not support single-ended.



Symbol	Туре	Function
TDQS, TDQS	Output	Termination Data Strobe: TDQS/TDQS is applicable for x8 DRAMs only. When enabled via Mode Register A11 = 1 in MR1, the DRAM will enable the same termination resistance function on TDQS/TDQS that is applied to DQS/DQS. When disabled via mode register A11 = 0 in MR1, DM/TDQS will provide the data mask function and TDQS is not used. x4 DRAMs must disable the TDQS function via mode register A11 = 0 in MR1.
NC		No Connect: No internal electrical connection is present.
NF		No Function
V <sub>DDQ</sub>	Supply	DQ Power Supply: 1.35 V +0.100/-0.067V
V <sub>SSQ</sub>	Supply	DQ Ground
V <sub>DD</sub>	Supply	Power Supply: 1.35 V +0.100/-0.067V
V <sub>SS</sub>	Supply	Ground
V <sub>REFDQ</sub>	Supply	Reference voltage for DQ
V <sub>REFCA</sub>	Supply	Reference voltage for CA
ZQ	Supply	Reference Pin for ZQ calibration

Note:

Input only pins (BA0-BA2, A0-A15, RAS, CAS, WE, CS, CKE, ODT, DM, and RESET) do not supply termination.

# ROW AND COLUMN ADDRESS TABLE

#### 2Gb

Configuration	256Mb x 8	128Mb x 16
# of Banks	8	8
Bank Address	BAO - BA2	BA0 - BA2
Auto precharge	A10/AP	A10/AP
BL switch on the fly	A12/BC	A12/BC
Row Address	A0 - A14	A0 - A13
Column Address	A0 - A9	A0 - A9
Page size <sup>1</sup>	1 KB	2 KB



**Note1:** Page size is the number of bytes of data delivered from the array to the internal sense amplifiers when an ACTIVE command is registered. Page size is per bank, calculated as follows:

page size = 2 <sup>COLBITS</sup> \* ORG ÷ 8

where COLBITS = the number of column address bits, ORG = the number of I/O (DQ) bits

# **Absolute Maximum Ratings**

#### **Absolute Maximum DC Ratings**

#### **Absolute Maximum DC Ratings**

Symbol	Parameter	Rating	Units	Notes
VDD	Voltage on VDD pin relative to Vss	- 0.4 V ~ 1.80 V	V	1,3
VDDQ	Voltage on VDDQ pin relative to Vss	- 0.4 V ~ 1.80 V	V	1,3
V <sub>IN</sub> , V <sub>OUT</sub>	Voltage on any pin relative to Vss	- 0.4 V ~ 1.80 V	V	1
T <sub>STG</sub>	Storage Temperature	-55 to +100	°C	1, 2



#### **Absolute Maximum DC Ratings**

#### Notes:

- 1. Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- 2. Storage Temperature is the case surface temperature on the center/top side of the DRAM. For the measurement conditions, please refer to JESD51-2 standard.
- 3. VDD and VDDQ must be within 300mV of each other at all times; and VREF must not be greater than 0.6XVDDQ, When VDD and VDDQ are less than 500mV; VREF may be equal to or less than 300mV.

#### DRAM Component Operating Temperature Range

Symbol	Parameter	Rating	Units	Notes
	Normal Operating Temperature Range	0 to 85	°C	1,2
T <sub>OPER</sub>	Extended Temperature Range	85 to 95	°C	1,4
OFER	Industrial Temperature Range	-40 to 95	°C	1,3,4

#### Temperature Range

Notes:

- 1. Operating Temperature TOPER is the case surface temperature on the center / top side of the DRAM. For measurement conditions, please refer to the JEDEC document JESD51-2.
- 2. The Normal Temperature Range specifies the temperatures where all DRAM specifications will be supported. During operation, the DRAM case temperature must be maintained between 0 85oC under all operating conditions.
- 3. The Industrial Temperature Range specifies the temperatures where all DRAM specifications will be supported. During operation, the DRAM case temperature must be maintained between -40 - 85oC under all operating conditions.
- 4. Some applications require operation of the DRAM in the Extended Temperature Range between 85oC and 95oC case temperature. Full specifications are guaranteed in this range, but the following additional conditions apply:
  - a. Refresh commands must be doubled in frequency, therefore reducing the Refresh interval tREFI to 3.9 µs.
  - b. If Self-Refresh operation is required in the Extended Temperature Range, then it is mandatory to use the Manual Self-Refresh mode with Extended Temperature Range capability (MR2 A6 = 0b and MR2 A7 = 1b).

# AC & DC Operating Conditions

#### **Recommended DC Operating Conditions**

#### Recommended DC Operating Conditions - DDR3L (1.35V) operation

			Rating				
Symbol	Parameter	Min.	Тур.	Max.	Units	Notes	
VDD	Supply Voltage	1.283	1.35	1.45	V	1,2,3,4	



VDDQ	Supply Voltage for Output	1.283	1.35	1.45	V	1,2,3,4
<b></b> .						

Notes:

- 1. Maximum DC value may not be greater than 1.425V. The DC value is the linear average of VDD/VDDQ (t) over a very long period of time (e.g., 1 sec).
- 2. If maximum limit is exceeded, input levels shall be governed by DDR3 specifications.
- 3. Under these supply voltages, the device operates to this DDR3L specification.
- 4. Once initialized for DDR3L operation, DDR3 operation may only be used if the device is in reset while VDD and VDDQ are changed for DDR3 operation (see Figure 0).

<b>Recommended DC Operating Conditions - D</b>	DDR3 (1.5V) operation
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			Rating		<b>.</b>		
Symbol	Parameter	Min.	Тур.	Max.	Units	Notes	
VDD	Supply Voltage	1.425	1.5	1.575	V	1,2,3	
VDDQ	Supply Voltage for Output	1.425	1.5	1.575	V	1,2,3	

Notes:

- 1. If minimum limit is exceeded, input levels shall be governed by DDR3L specifications.
- 2. Under 1.5V operation, this DDR3L device operates to the DDR3 specifications under the same speed timings as defined for this device.
- 3. Once initialized for DDR3 operation, DDR3L operation may only be used if the device is in reset while VDD and VDDQ are changed for DDR3L operation (see Figure 0).



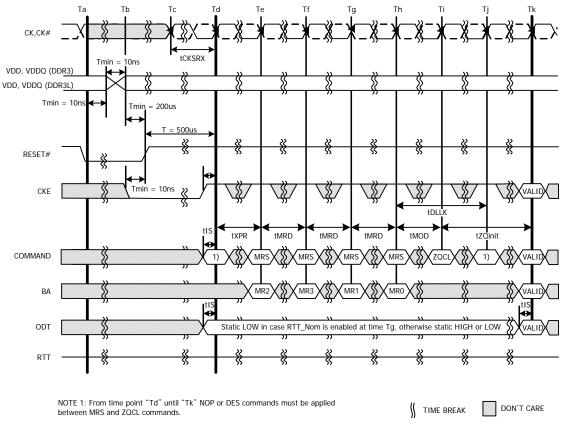


Figure 0 - VDD/VDDQ Voltage Switch Between DDR3L and DDR3L



# IDD and IDDQ Specification Parameters and Test Conditions

#### IDD and IDDQ Measurement Conditions

In this chapter, IDD and IDDQ measurement conditions such as test load and patterns are defined. Figure 1. shows the setup and test load for IDD and IDDQ measurements.

- IDD currents (such as IDD0, IDD1, IDD2N, IDD2NT, IDD2P0, IDD2P1, IDD2Q, IDD3N, IDD3P, IDD4R, IDD4W, IDD5B, IDD6, IDD6ET and IDD7) are measured as time-averaged currents with all VDD balls of the DDR3L SDRAM under test tied together. Any IDDQ current is not included in IDD currents.
- IDDQ currents (such as IDDQ2NT and IDDQ4R) are measured as time-averaged currents with all VDDQ balls of the DDR3L SDRAM under test tied together. Any IDD current is not included in IDDQ currents.

Attention: IDDQ values cannot be directly used to calculate IO power of the DDR3L SDRAM. They can be used to support correlation of simulated IO power to actual IO power as outlined in Figure 2. In DRAM module application, IDDQ cannot be measured separately since VDD and VDDQ are using one merged-power layer in Module PCB.

For IDD and IDDQ measurements, the following definitions apply:

- "0" and "LOW" is defined as VIN  $\leq V_{ILAC(max)}$ .
- "1" and "HIGH" is defined as VIN >= V<sub>IHAC(max)</sub>.
- "MID\_LEVEL" is defined as inputs are VREF = VDD/2.
- Timing used for IDD and IDDQ Measurement-Loop Patterns are provided in Table 1.
- Basic IDD and IDDQ Measurement Conditions are described in Table 2.
- Detailed IDD and IDDQ Measurement-Loop Patterns are described in Table 3 through Table 10.
- IDD Measurements are done after properly initializing the DDR3L SDRAM. This includes but is not limited to setting RON = RZQ/7 (34 Ohm in MR1);
  - Qoff =  $0_B$  (Output Buffer enabled in MR1); RTT\_Nom = RZQ/6 (40 Ohm in MR1); RTT\_Wr = RZQ/2 (120 Ohm in MR2);
  - TDQS Feature disabled in MR1
- Attention: The IDD and IDDQ Measurement-Loop Patterns need to be executed at least one time before actual IDD or IDDQ measurement is started.
- Define D = { $\overline{CS}$ ,  $\overline{RAS}$ ,  $\overline{CAS}$ ,  $\overline{WE}$ }:= {HIGH, LOW, LOW, LOW}
- Define  $\overline{D} = \{\overline{CS}, \overline{RAS}, \overline{CAS}, \overline{WE}\} := \{HIGH, HIGH, HIGH, HIGH\}$



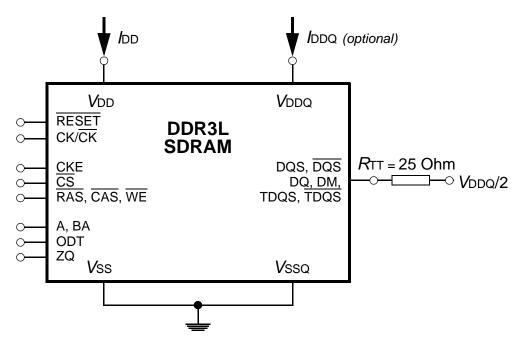
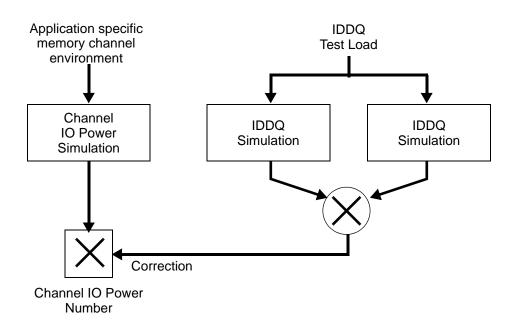
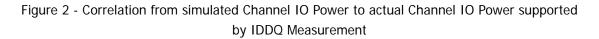


Figure 1 - Measurement Setup and Test Load for IDD and IDDQ (optional) Measurements [Note: DIMM level Output test load condition may be different from above]





Rev. 1.3 / Nov. 2015



	Sumphal	DDR3L-1066	DDR3L-1333	DDR3L-1600	DDR3L-1866	llmit
	Symbol	7-7-7	9-9-9	11-11-11	13-13-13	Unit
t <sub>CK</sub>		1.875	1.5	1.25	1.07	ns
CL		7	9	11	13	nCK
<i>n</i> <sub>RCD</sub>		7	9	11	13	nCK
n <sub>RC</sub>		27	33	39	45	nCK
n <sub>RAS</sub>		20	24	28	32	nCK
n <sub>RP</sub>		7	9	11	13	nCK
	1KB page size			24	26	nCK
n <sub>FAW</sub>	2KB page size	27	30	32	33	nCK
	1KB page size	4	4	5	5	nCK
n <sub>RRD</sub>	2KB page size	6	5 6		6	nCK
n <sub>RFC</sub> -	512Mb	48	60	72	85	nCK
<i>п</i> <sub>RFC</sub> -1	l Gb	59	74	88	103	nCK
n <sub>RFC</sub> -		86	107	128	150	nCK
n <sub>RFC</sub> -	4 Gb	139	174	208	243	nCK
n <sub>RFC</sub> -	8 Gb	187	234	280	328	nCK

#### Table 1 -Timings used for IDD and IDDQ Measurement-Loop Patterns

#### Table 2 - Basic IDD and IDDQ Measurement Conditions

Symbol	Description
	Operating One Bank Active-Precharge Current
	CKE: High; External clock: On; tCK, nRC, nRAS, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: High between ACT
1	and PRE; Command, Address, Bank Address Inputs: partially toggling according to Table 3; Data IO:
<b>J</b> <sub>DD0</sub>	MID-LEVEL; DM: stable at 0; Bank Activity: Cycling with one bank active at a time: 0,0,1,1,2,2, (see
	Table 3); Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: stable at 0; Pattern Details:
	see Table 3.



JDD1       Operating One Bank Active-Precharge Current         CKE: High; External clock: On; tCK, nRC, nRAS, nRCD, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS. High between         ACT, RD and PRE; Command, Address; Bank Address Inputs, Data IO: partially toggling according to         Table 4; DM: stable at 0; Bank Activity: Cycling with on bank active at a time: 0,0,1,1,2,2, (see Table 4); Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ; ODT Signal: stable at 0; Pattern Details: see         Table 4.         Precharge Standby Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0;         Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0;         Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0;         Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0;         Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: tog-gling according to Table 6; Pattern Details: see Table 6.         Precharge Power-Down Current         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ; AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;         Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ; ODT Signal: sta	Symbol	Description
ACT, RD and PRE; Command, Address; Bank Address Inputs, Data IO: partially toggling according to         Table 4; DM: stable at 0; Bank Activity: Cycling with on bank active at a time: 0,0,1,1,2,2, (see Table 4); Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ; ODT Signal: stable at 0; Pattern Details: see         Table 4.         Precharge Standby Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0;         Bank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0;         Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ; ODT Signal: stable at 0; Pattern Details: see Table 5.         Precharge Standby ODT Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0;         Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: tog-gling according to Table 6; Pattern Details: see Table 6.         Precharge Power-Down Current Slow Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down Mode: Slow Exit <sup>c</sup> )         Precharge Power-Down Current Fast Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command,		Operating One Bank Active-Precharge Current
<b>fob1</b> Table 4; DM: stable at 0; Bank Activity: Cycling with on bank active at a time: 0,0,1,1,2,2, (see Table 4); Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ; ODT Signal: stable at 0; Pattern Details: see Table 4. <b>Precharge Standby Current</b> CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Pattern Details: see Table 5. <b>foD2N</b> Precharge Standby ODT Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; Bank Adtivity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: tog-gling according to Table 6; Pattern Details: see Table 6. <b>foD2P0</b> Precharge Power-Down Current Slow Exit <b>foD2P0</b> CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down Mode: Slow Exit <sup>c</sup> ) <b>foD2P0</b> Precharge Power-Down Current Fast Exit <b>foD2P1</b> Precharge Power-Down Current Fast Exit <b>f</b> _DD2P1       Bank Address Inputs: stable at 0; Data I		CKE: High; External clock: On; tCK, nRC, nRAS, nRCD, CL: see Table 1; BL: 8 <sup>a)</sup> ; AL: 0; CS: High between
Table 4; DM: stable at 0; Bank Activity: Cycling with on bank active at a time: 0,0,1,1,2,2, (see Table 4); Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Pattern Details: see Table 4.         Precharge Standby Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Pattern Details: see Table 5.         Precharge Standby ODT Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: tog-gling according to Table 6; Pattern Details: see Table 6.         Precharge Power-Down Current Slow Exit       CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down Mode: Slow Exit <sup>C</sup> )         Precharge Power-Down Current Fast Exit       CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activi	<b>I</b>	ACT, RD and PRE; Command, Address; Bank Address Inputs, Data IO: partially toggling according to
Table 4.         Precharge Standby Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 5; Data 10: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Pattern Details: see Table 5.         Precharge Standby ODT Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 6; Data 10: MID_LEVEL; DM: stable at 0; Bank Address Inputs: partially toggling according to Table 6; Data 10: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: tog- gling according to Table 6; Pattern Details: see Table 6.         Precharge Power-Down Current Slow Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data 10: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Precharge Power Down Mode: Slow Exit <sup>(c)</sup> Precharge Power-Down Current Fast Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data 10: MID_LEVEL; DM: stable at 0; Precharge Power Down Mode: Slow Exit <sup>(c)</sup> Precharge Power-Down Current Fast Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable	'DD1	Table 4; DM: stable at 0; Bank Activity: Cycling with on bank active at a time: 0,0,1,1,2,2, (see Table
Precharge Standby Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0;         Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0;         Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Pattern Details: see Table 5.         Precharge Standby ODT Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0;         Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: tog-gling according to Table 6; Pattern Details: see Table 6.         Precharge Power-Down Current Slow Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down         Mode: Slow Exit <sup>(C)</sup> Precharge Power-Down Current Fast Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down         Mode: Slow Exit <sup>(C)</sup> Precharge Power-Down Current Fast Exit <th></th> <td>4); Output Buffer and RTT: Enabled in Mode Registers<sup>b)</sup>; ODT Signal: stable at 0; Pattern Details: see</td>		4); Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: stable at 0; Pattern Details: see
IDD2N       CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Pattern Details: see Table 5.         Precharge Standby ODT Current       CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: toggling according to Table 6; Pattern Details: see Table 6.         Precharge Power-Down Current Slow Exit       CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: toggling according to Table 6; Pattern Details: see Table 6.         Precharge Power-Down Current Slow Exit       CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down Mode: Slow Exit <sup>c</sup> )         Precharge Power-Down Current Fast Exit       CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ; AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;         JDD2P1       Precharge Power-Down Current Fast Exit		Table 4.
JDD2NBank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Pattern Details: see Table 5.JDD2NTPrecharge Standby ODT Current CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: tog- gling according to Table 6; Pattern Details: see Table 6.JDD2POPrecharge Power-Down Current Slow Exit CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down Mode: Slow Exit <sup>C</sup> )JDD2P0Precharge Power-Down Current Fast Exit CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down Mode: Slow Exit <sup>C</sup> )JDD2P1Precharge Power-Down Current Fast Exit CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;		Precharge Standby Current
Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: stable at 0; Pattern Details: see Table 5.Precharge Standby ODT CurrentCKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: tog- gling according to Table 6; Pattern Details: see Table 6.Precharge Power-Down Current Slow Exit CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: tog- gling according to Table 6; Pattern Details: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down Mode: Slow Exit <sup>C</sup> ) <b>/</b> DD2P0Precharge Power-Down Current Fast Exit CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;		CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a)</sup> ; AL: 0; CS: stable at 1; Command, Address,
at 0; Pattern Details: see Table 5.         Precharge Standby ODT Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0;         Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: tog-gling according to Table 6; Pattern Details: see Table 6.         Precharge Power-Down Current Slow Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;         Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Bank Activity: all banks closed;         Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Precharge Power Down         Mode: Slow Exit <sup>c</sup> )         Precharge Power-Down Current Fast Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down         Mode: Slow Exit <sup>c</sup> )         Precharge Power-Down Current Fast Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; <th>I<sub>DD2N</sub></th> <td>Bank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0;</td>	I <sub>DD2N</sub>	Bank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0;
Precharge Standby ODT CurrentCKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: tog- gling according to Table 6; Pattern Details: see Table 6.Precharge Power-Down Current Slow Exit CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Precharge Power Down Mode: Slow Exit <sup>C</sup> )Precharge Power-Down Current Fast Exit CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down Mode: Slow Exit <sup>C</sup> )Precharge Power-Down Current Fast Exit CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;		Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: stable
IDD2NTCKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: tog- gling according to Table 6; Pattern Details: see Table 6.Precharge Power-Down Current Slow Exit CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Precharge Power Down Mode: Slow Exit <sup>C</sup> )IDD2P1Precharge Power-Down Current Fast Exit CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down Mode: Slow Exit <sup>C</sup> )IDD2P1Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down Current Fast Exit CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down Mode: Slow Exit <sup>C</sup> )		at 0; Pattern Details: see Table 5.
JDD2NTBank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: tog- gling according to Table 6; Pattern Details: see Table 6.Precharge Power-Down Current Slow ExitPrecharge Power-Down Current Slow ExitJDD2P0CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Precharge Power Down Mode: Slow Exit <sup>C</sup> JDD2P0Precharge Power-Down Current Fast Exit CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down Mode: Slow Exit <sup>C</sup> )JDD2P1Precharge Power-Down Current Fast Exit CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;		Precharge Standby ODT Current
Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ; ODT Signal: tog-gling according to Table 6; Pattern Details: see Table 6.         Precharge Power-Down Current Slow Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;         Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ; ODT Signal: stable at 0; Precharge Power Down         Mode: Slow Exit <sup>C</sup> Precharge Power-Down Current Fast Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down         Mode: Slow Exit <sup>C</sup> Precharge Power-Down Current Fast Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;		CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a)</sup> ; AL: 0; CS: stable at 1; Command, Address,
gling according to Table 6; Pattern Details: see Table 6.         Precharge Power-Down Current Slow Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;         Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ; ODT Signal: stable at 0; Precharge Power Down         Mode: Slow Exit <sup>c</sup> )         Precharge Power-Down Current Fast Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ; AL: 0; CS: stable at 1; Command, Address,         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;	I <sub>DD2NT</sub>	Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0;
<ul> <li>Precharge Power-Down Current Slow Exit</li> <li>CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8<sup>a</sup>); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers<sup>b</sup>); ODT Signal: stable at 0; Precharge Power Down Mode: Slow Exit<sup>c</sup>)</li> <li>Precharge Power-Down Current Fast Exit</li> <li>CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8<sup>a</sup>); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Precharge Power Down Mode: Slow Exit<sup>c</sup>)</li> </ul>		Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: tog-
<ul> <li>Image: Construction of the second state of the state of</li></ul>		gling according to Table 6; Pattern Details: see Table 6.
Image: Model Slow Exit <sup>c</sup> )       Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0; Precharge Power Down Mode: Slow Exit <sup>c</sup> )         Image: Model Model Model Registers <sup>b</sup> ); ODT Signal: stable at 0; Precharge Power Down Current Fast Exit         Image: Model Registers Mo		Precharge Power-Down Current Slow Exit
Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: stable at 0; Precharge Power Down Mode: Slow Exit <sup>c)</sup> Precharge Power-Down Current Fast Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;		CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,
Mode: Slow Exit <sup>c</sup> )         Precharge Power-Down Current Fast Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         JDD2P1         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;	<b>/</b> <sub>DD2P0</sub>	Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;
Precharge Power-Down Current Fast Exit         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,         JDD2P1         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;		Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: stable at 0; Precharge Power Down
CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address, <b>J</b> <sub>DD2P1</sub> Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;		Mode: Slow Exit <sup>c)</sup>
<b>J</b> <sub>DD2P1</sub> Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;		Precharge Power-Down Current Fast Exit
		CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a)</sup> ; AL: 0; CS: stable at 1; Command, Address,
Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: stable at 0; Precharge Power Down	<b>/</b> <sub>DD2P1</sub>	Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;
		Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: stable at 0; Precharge Power Down
Mode: Fast Exit <sup>c)</sup>		Mode: Fast Exit <sup>c)</sup>
Precharge Quiet Standby Current		Precharge Quiet Standby Current
CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Address,	<b>In</b> ===	CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a)</sup> ; AL: 0; CS: stable at 1; Command, Address,
<b>J</b> <sub>DD2Q</sub> Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;	UD2Q	Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed;
Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ; ODT Signal: stable at 0		Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: stable at 0



Active Standby Current         Active Standby Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a)</sup> ; AL: 0; CS: stable at 1; Command, Addr         Bank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0;         Bank Activity: all banks open; Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: sta         at 0; Pattern Details: see Table 5.         Active Power-Down Current         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a)</sup> ; AL: 0; CS: stable at 1; Command, Addr         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks op         Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: stable at 0         Operating Burst Read Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: High between RD; Command         Address, Bank Address Inputs: partially toggling according to Table 7; Data IO: seamless read data b         with different data between one burst and the next one according to Table 7; DM: stable at 0; Bank         Activity: all banks open, RD commands cycling through banks: 0,0,1,1,2,2,(see Table 7); Output Buf
JDD3N       Bank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0;         Bank Activity: all banks open; Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: state at 0; Pattern Details: see Table 5.         Active Power-Down Current         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Addr         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks op         Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ; ODT Signal: stable at 0         Operating Burst Read Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: High between RD; Comman         Address, Bank Address Inputs: partially toggling according to Table 7; DAta IO: seamless read data b         with different data between one burst and the next one according to Table 7; DM: stable at 0; Bank
At 0; Pattern Details: see Table 5.         Active Power-Down Current         CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Addr         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks op         Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0         Operating Burst Read Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: High between RD; Comman         Address, Bank Address Inputs: partially toggling according to Table 7; Data IO: seamless read data b         with different data between one burst and the next one according to Table 7; DM: stable at 0; Bank
IDD3P       CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: stable at 1; Command, Addr         Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks op         Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ); ODT Signal: stable at 0         Operating Burst Read Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: High between RD; Comman         Address, Bank Address Inputs: partially toggling according to Table 7; Data IO: seamless read data b         with different data between one burst and the next one according to Table 7; DM: stable at 0; Bank
JDD3P       Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks op Output Buffer and RTT: Enabled in Mode Registers <sup>b</sup> ; ODT Signal: stable at 0         Operating Burst Read Current       Operating Burst Read Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: High between RD; Comman Address, Bank Address Inputs: partially toggling according to Table 7; Data IO: seamless read data b with different data between one burst and the next one according to Table 7; DM: stable at 0; Bank
Joda       Operating Burst Read Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: High between RD; Comman         Address, Bank Address Inputs: partially toggling according to Table 7; Data IO: seamless read data b         with different data between one burst and the next one according to Table 7; DM: stable at 0; Bank
Joda       Operating Burst Read Current         CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: High between RD; Comman         Address, Bank Address Inputs: partially toggling according to Table 7; Data IO: seamless read data b         with different data between one burst and the next one according to Table 7; DM: stable at 0; Bank
<b>J</b> <sub>DD4R</sub> Address, Bank Address Inputs: partially toggling according to Table 7; Data IO: seamless read data b with different data between one burst and the next one according to Table 7; DM: stable at 0; Bank
<b>7</b> DD4R with different data between one burst and the next one according to Table 7; DM: stable at 0; Bank
and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: stable at 0; Pattern Details: see Table 7.
Operating Burst Write Current
CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 <sup>a</sup> ); AL: 0; CS: High between WR; Commar
Address, Bank Address Inputs: partially toggling according to Table 8; Data IO: seamless read data b
<b>V</b> <sub>DD4W</sub> with different data between one burst and the next one according to Table 8; DM: stable at 0; Bank
Activity: all banks open, WR commands cycling through banks: 0,0,1,1,2,2,(see Table 8); Output
fer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: stable at HIGH; Pattern Details: see Table 8
Burst Refresh Current
CKE: High; External clock: On; tCK, CL, nRFC: see Table 1; BL: 8 <sup>a)</sup> ; AL: 0; CS: High between REF; C
Ирото mand, Address, Bank Address Inputs: partially toggling according to Table 9; Data IO: MID_LEVEL;
stable at 0; Bank Activity: REF command every nREF (see Table 9); Output Buffer and RTT: Enabled
Mode Registers <sup>b)</sup> ; ODT Signal: stable at 0; Pattern Details: see Table 9.
Self-Refresh Current: Normal Temperature Range
T <sub>CASE</sub> : 0 - 85 <sup>o</sup> C; Auto Self-Refresh (ASR): Disabled <sup>d)</sup> ; Self-Refresh Temperature Range (SRT): Norma
/DD6 CKE: Low; External clock: Off; CK and CK: LOW; CL: see Table 1; BL: 8 <sup>a)</sup> ; AL: 0; CS, Command, Addr
Bank Address Inputs, Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: Self-Refresh operation; (
put Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal: MID_LEVEL



Symbol	Description
	Self-Refresh Current: Extended Temperature Range
	T <sub>CASE</sub> : 0 - 95 °C; Auto Self-Refresh (ASR): Disabled <sup>d)</sup> ;Self-Refresh Temperature Range (SRT): Extend-
I <sub>DD6ET</sub>	ed <sup>e)</sup> ; CKE: Low; External clock: Off; CK and $\overline{CK}$ : LOW; CL: see Table 1; BL: 8 <sup>a)</sup> ; AL: 0; $\overline{CS}$ , Command,
	Address, Bank Address Inputs, Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: Extended Tempera-
	ture Self-Refresh operation; Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ; ODT Signal:
	MID_LEVEL
	Operating Bank Interleave Read Current
	CKE: High; External clock: On; tCK, nRC, nRAS, nRCD, NRRD, nFAW, CL: see Table 1; BL: 8 <sup>a), f)</sup> ; AL: CL-
	1; CS: High between ACT and RDA; Command, Address, Bank Address Inputs: partially toggling accord-
<b>I</b> <sub>DD7</sub>	ing to Table 10; Data IO: read data burst with different data between one burst and the next one
	according to Table 10; DM: stable at 0; Bank Activity: two times interleaved cycling through banks (0,
	1,7) with different addressing, wee Table 10; Output Buffer and RTT: Enabled in Mode Registers <sup>b)</sup> ;
	ODT Signal: stable at 0; Pattern Details: see Table 10.

a) Burst Length: BL8 fixed by MRS: set MR0 A[1,0]=00B

b) Output Buffer Enable: set MR1 A[12] = 0B; set MR1 A[5,1] = 01B; RTT\_Nom enable: set MR1 A[9,6,2] = 011B; RTT\_Wr enable: set MR2 A[10,9] = 10B

c) Precharge Power Down Mode: set MR0 A12=0B for Slow Exit or MR0 A12 = 1B for Fast Exit

d) Auto Self-Refresh (ASR): set MR2 A6 = 0B to disable or 1B to enable feature

e) Self-Refresh Temperature Range (SRT): set MR2 A7 = 0B for normal or 1B for extended temperature range

f) Read Burst Type: Nibble Sequential, set MR0 A[3] = 0B



# Table 3 - IDD0 Measurement-Loop Pattern<sup>a)</sup>

ck, cK	CKE	Sub-Loop	Cycle Number	Command	<u>cs</u>	RAS	CAS	WE	ODT	BA[2:0]	A[15:11]	A[10]	A[9:7]	A[6:3]	A[2:0]	Data <sup>b)</sup>	
		0	0	ACT	0	0	1	1	0	0	00	0	0	0	0	-	
			1,2	D, D	1	0	0	0	0	0	00	0	0	0	0	-	
			3,4	$\overline{D}, \overline{D}$	1	1	1	1	0	0	00	0	0	0	0	-	
				repeat	patter	m 1	4 unti	l nRAS	S - 1, †	trunca	te if n	ecess	ary				
			nRAS	PRE	0	0	1	0	0	0	00	0	0	0	0	-	
				repeat	epeat pattern 14 until nRC - 1, truncate if necessary												
	Static High		1*nRC+0	ACT	0	0	1	1	0	0	00	0	0	F	0	-	
		5	1*nRC+1, 2	D, D	1	0	0	0	0	0	00	0	0	F	0	-	
bu			1*nRC+3, 4	D, D	1	1	1	1	0	0	00	0	0	F	0	-	
toggling	tic F			repeat	repeat pattern 14 until 1*nRC + nRAS - 1, truncate if necessary												
to	Sta		1*nRC+nRAS	PRE	0	0	1	0	0	0	00	0	0	F	0	-	
				repeat	patte	rn 1	4 unti	l 2*nF	RC - 1,	trunc	ate if	neces	sary				
		1	2*nRC	repeat	Sub-L	.oop C	), use	BA[2:	0] = 1	inste	ad						
		2	4*nRC	repeat	Sub-L	.oop C	), use	BA[2:	0] = 2	inste	ad						
		3	6*nRC	repeat	Sub-L	.oop C	), use	BA[2:	0] = 3	inste	ad						
		4	8*nRC	repeat	Sub-L	.oop C	), use	BA[2:	0] = 4	inste	ad						
		5	10*nRC	repeat	Sub-L	.oop C	), use	BA[2:	0] = 5	inste	ad						
		6	12*nRC	repeat	Sub-L	.oop C	), use	BA[2:	0] = 6	inste	ad						
		7	14*nRC	repeat	Sub-L	.oop C	), use	BA[2:	0] = 7	' inste	ad						

a) DM must be driven LOW all the time. DQS,  $\overline{\text{DQS}}$  are MID-LEVEL.

b) DQ signals are MID-LEVEL.



Table 4 - IDD1	I Measurement-Loop Pattern <sup>a)</sup>
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ck, cK	CKE	Sub-Loop	Cycle Number	Command	<u>cs</u>	RAS	CAS	WE	ODT	BA[2:0]	A[15:11]	A[10]	A[9:7]	A[6:3]	A[2:0]	Data <sup>b)</sup>
		0	0	ACT	0	0	1	1	0	0	00	0	0	0	0	-
			1,2	D, D	1	0	0	0	0	0	00	0	0	0	0	-
	Static High		3,4	D, D	1	1	1	1	0	0	00	0	0	0	0	-
				repeat	patte	rn 1	4 unti	I nRCI	D - 1,	trunca	ite if n	ecess	ary			
			nRCD	RD	0	1	0	1	0	0	00	0	0	0	0	00000000
				repeat	patte	rn 1	4 unti	l nRAS	5 - 1, t	runca	te if ne	ecessa	ary			
			nRAS	PRE	0	0	1	0	0	0	00	0	0	0	0	-
				repeat	repeat pattern 14 until nRC - 1, truncate if necessary											
			1*nRC+0	ACT	0	0	1	1	0	0	00	0	0	F	0	-
			1*nRC+1,2	D, D	1	0	0	0	0	0	00	0	0	F	0	-
bu			1*nRC+3,4	D, D	1	1	1	1	0	0	00	0	0	F	0	-
toggling	tic F			repeat	repeat pattern nRC + 1,4 until nRC + nRCE - 1, truncate if necessary											
to	Sta		1*nRC+nRCD	RD	0	1	0	1	0	0	00	0	0	F	0	00110011
				repeat	patte	rn nR(	C + 1,	4 ur	ntil nR	C + n	RAS -	1, trui	ncate	if nece	ssary	
			1*nRC+nRAS	PRE	0	0	1	0	0	0	00	0	0	F	0	-
				repeat	patte	rn nR(	C + 1,	4 ur	ntil *2	nRC -	1, tru	ncate	if nec	essary		
		1	2*nRC	repeat	Sub-L	.oop C	), use	BA[2:	0] = 1	instea	ad					
		2	4*nRC	repeat	Sub-L	.oop C	), use	BA[2:	0] = 2	inste	ad					
		3	6*nRC	repeat	Sub-L	.oop C	), use	BA[2:	0] = 3	inste	ad					
		4	8*nRC	repeat	Sub-L	.oop C	), use	BA[2:	0] = 4	inste	ad					
		5	10*nRC	repeat	Sub-L	.oop C	), use	BA[2:	0] = 5	inste	ad					
		6	12*nRC	repeat	Sub-L	.oop C	), use	BA[2:	0] = 6	inste	ad					
		7	14*nRC	repeat	Sub-L	oop C	), use	BA[2:	0] = 7	inste	ad					

a) DM must be driven LOW all the time. DQS, DQS are used according to RD Commands, otherwise MID-LEVEL.
b) Burst Sequence driven on each DQ signal by Read Command. Outside burst operation, DQ signals are MID\_LEVEL.



ск, <u>ск</u>	CKE	Sub-Loop	Cycle Number	Command	<u>cs</u>	RAS	CAS	WE	ODT	BA[2:0]	A[15:11]	A[10]	A[9:7]	A[6:3]	A[2:0]	Data <sup>b)</sup>
	High	0	0	D	1	0	0	0	0	0	0	0	0	0	0	-
			1	D	1	0	0	0	0	0	0	0	0	0	0	-
			2	D	1	1	1	1	0	0	0	0	0	F	0	-
			3	D	1	1	1	1	0	0	0	0	0	F	0	-
gr		1	4-7	repeat Sub-Loop 0, use BA[2:0] = 1 instead												
toggling		2	8-11	repeat	repeat Sub-Loop 0, use BA[2:0] = 2 instead											
to	Static	3	12-15	repeat	Sub-L	.oop 0	, use	BA[2:0	)] = 3	instea	d					
		4	16-19	repeat	Sub-L	.oop 0	, use	BA[2:0	)] = 4	instea	d					
		5	20-23	repeat	Sub-L	.oop 0	, use	BA[2:0	)] = 5	instea	d					
		6	24-17	repeat	Sub-L	.oop 0	, use	BA[2:0	)] = 6	instea	d					
		7	28-31	repeat	Sub-L	.oop 0	, use	BA[2:0	)] = 7	instea	d					

# Table 5 - IDD2N and IDD3N Measurement-Loop Pattern<sup>a)</sup>

a) DM must be driven LOW all the time. DQS, DQS are MID-LEVEL.

b) DQ signals are MID-LEVEL.

ск, <u>ск</u>	CKE	Sub-Loop	Cycle Number	Command	CS	RAS	CAS	WE	ODT	BA[2:0]	A[15:11]	A[10]	A[9:7]	A[6:3]	A[2:0]	Data <sup>b)</sup>
		0	0	D	1	0	0	0	0	0	0	0	0	0	0	-
			1	D	1	0	0	0	0	0	0	0	0	0	0	-
			2	D	1	1	1	1	0	0	0	0	0	F	0	-
			3	D	1	1	1	1	0	0	0	0	0	F	0	-
bu	High	1	4-7	repeat	Sub-L	.oop 0	, but	ODT =	= 0 and	d BA[2	2:0] =	1				
toggling		2	8-11	repeat	Sub-L	.oop 0	, but	ODT =	= 1 and	d BA[2	2:0] =	2				
to	Static	3	12-15	repeat	Sub-L	.oop 0	, but	ODT =	= 1 and	d BA[2	2:0] =	3				
		4	16-19	repeat	Sub-L	.oop 0	, but	ODT =	= 0 and	d BA[2	2:0] =	4				
		5	20-23	repeat Sub-Loop 0, but ODT = 0 and BA[2:0] = 5												
		6	24-17	repeat Sub-Loop 0, but ODT = 1 and BA[2:0] = 6												
		7	28-31	repeat Sub-Loop 0, but ODT = 1 and BA[2:0] = 7												

# Table 6 - IDD2NT and IDDQ2NT Measurement-Loop Pattern<sup>a)</sup>

a) DM must be driven LOW all the time. DQS,  $\overline{\text{DQS}}$  are MID-LEVEL.

b) DQ signals are MID-LEVEL.



ck, cK	CKE	Sub-Loop	Cycle Number	Command	CS	RAS	CAS	WE	ODT	BA[2:0]	A[15:11]	A[10]	A[9:7]	A[6:3]	A[2:0]	Data <sup>b)</sup>
		0	0	RD	0	1	0	1	0	0	00	0	0	0	0	00000000
			1	D	1	0	0	0	0	0	00	0	0	0	0	-
			2,3	D,D	1	1	1	1	0	0	00	0	0	0	0	-
			4	RD	0	1	0	1	0	0	00	0	0	F	0	00110011
			5	D	1	0	0	0	0	0	00	0	0	F	0	-
bu	High		6,7	D,D	1	1	1	1	0	0	00	0	0	F	0	-
toggling		1	8-15	repeat	Sub-L	.oop C	, but	BA[2:0	)] = 1							
to	Static	2	16-23	repeat	Sub-L	.oop C	, but	BA[2:0	)] = 2							
		3	24-31	repeat	Sub-L	.oop C	, but	BA[2:0	0] = 3							
		4	32-39	repeat	Sub-L	.oop 0	, but	BA[2:0	0] = 4							
		5	40-47	repeat	Sub-L	.oop C	, but	BA[2:0	)] = 5							
		6	48-55	repeat	Sub-L	.oop C	, but	BA[2:0	)] = 6							
		7	56-63	repeat	Sub-L	.oop C	, but	BA[2:0	)] = 7							

# Table 7 - IDD4R and IDDQ4R Measurement-Loop Pattern<sup>a)</sup>

a) DM must be driven LOW all the time. DQS, DQS are used according to RD Commands, otherwise MID-LEVEL.

b) Burst Sequence driven on each DQ signal by Read Command. Outside burst operation, DQ signals are MID-LEVEL.



ck, <u>ck</u>	CKE	Sub-Loop	Cycle Number	Command	CS	RAS	CAS	WE	ODT	BA[2:0]	A[15:11]	A[10]	A[9:7]	A[6:3]	A[2:0]	Data <sup>b)</sup>
		0	0	WR	0	1	0	0	1	0	00	0	0	0	0	00000000
			1	D	1	0	0	0	1	0	00	0	0	0	0	-
			2,3	D,D	1	1	1	1	1	0	00	0	0	0	0	-
			4	WR	0	1	0	0	1	0	00	0	0	F	0	00110011
			5	D	1	0	0	0	1	0	00	0	0	F	0	-
bu	High		6,7	D,D	1	1	1	1	1	0	00	0	0	F	0	-
toggling	tic F	1	8-15	repeat	Sub-L	.oop 0	, but I	BA[2:0	)] = 1							
to	Static	2	16-23	repeat	Sub-L	.oop 0	, but	BA[2:0	)] = 2							
		3	24-31	repeat	Sub-L	.oop 0	, but	BA[2:0	0] = 3							
		4	32-39	repeat	Sub-L	.oop 0	, but	BA[2:0	0] = 4							
		5	40-47	repeat	Sub-L	.oop 0	, but	BA[2:0	0] = 5							
		6	48-55	repeat	Sub-L	.oop 0	, but	BA[2:0	0] = 6							
		7	56-63	repeat	Sub-L	.oop 0	, but	BA[2:0	0] = 7							

# Table 8 - IDD4W Measurement-Loop Pattern<sup>a)</sup>

a) DM must be driven LOW all the time. DQS, DQS are used according to WR Commands, otherwise MID-LEVEL.
b) Burst Sequence driven on each DQ signal by Write Command. Outside burst operation, DQ signals are MID-LEVEL.

ск, <u>ск</u>	CKE	Sub-Loop	Cycle Number	Command	<u>cs</u>	RAS	CAS	WE	ODT	BA[2:0]	A[15:11]	A[10]	A[9:7]	A[6:3]	A[2:0]	Data <sup>b)</sup>
		0	0	REF	0	0	0	1	0	0	0	0	0	0	0	-
		1	1.2	D, D	1	0	0	0	0	0	00	0	0	0	0	-
			3,4	D, D	1	1	1	1	0	0	00	0	0	F	0	-
			58	repeat	epeat cycles 14, but BA[2:0] = 1											
bu	High		912	repeat	epeat cycles 14, but BA[2:0] = 2											
toggling			1316	repeat	cycles	5 14	, but	BA[2:0	)] = 3							
to	Static		1720	repeat	cycles	5 14	, but	BA[2:0	)] = 4							
			2124	repeat	cycles	s 14	, but	BA[2:0	)] = 5							
			2528	repeat cycles 14, but BA[2:0] = 6												
			2932	repeat cycles 14, but BA[2:0] = 7												
		2	33nRFC-1	repeat Sub-Loop 1, until nRFC - 1. Truncate, if necessary.												

Table 9 - IDD5B Measurement-Loop Pattern<sup>a)</sup>

a) DM must be driven LOW all the time. DQS,  $\overline{\text{DQS}}$  are MID-LEVEL.

b) DQ signals are MID-LEVEL.



#### Table 10 - IDD7 Measurement-Loop Pattern<sup>a)</sup>

ATTENTION! Sub-Loops 10-19 have inverse A[6:3] Pattern and Data Pattern than Sub-Loops 0-9

ck, ck	CKE	Sub-Loop	Cycle Number	Command	CS	RAS	CAS	WE	ODT	BA[2:0]	A[15:11]	A[10]	A[9:7]	A[6:3]	A[2:0]	Data <sup>b)</sup>
		0	0	ACT	0	0	1	1	0	0	00	0	0	0	0	-
			1	RDA	0	1	0	1	0	0	00	1	0	0	0	00000000
			2	D	1	0	0	0	0	0	00	0	0	0	0	-
				repeat	above	e D C	omma	ind ur	itil nR	RD - 1	1	1	1		1	
			nRRD	ACT	0	0	1	1	0	1	00	0	0	F	0	-
		1	nRRD+1	RDA	0	1	0	1	0	1	00	1	0	F	0	00110011
		1	nRRD+2	D	1	0	0	0	0	1	00	0	0	F	0	-
				repeat	above	e D C	omma	ind ur	ntil 2*	nRRD	) - 1			1		
		2	2*nRRD	repeat	Sub-L	oop (	), but	BA[2	= [0:	2						
		3	3*nRRD	repeat	Sub-L	_oop ´	I, but	BA[2	= [0:	3						
		4	4*nRRD	D	1	0	0	0	0	3	00	0	0	F	0	-
		4		Assert							itil nFA	W -	1, if n	ecessa	ary	
		5	nFAW	repeat	Sub-L	_oop (	), but	BA[2	= [0:	4						
		6	nFAW+nRRD	repeat	Sub-L	_oop ´	I, but	BA[2	= [0:	5						
		7	nFAW+2*nRRD	repeat		•		-	-							
		8	nFAW+3*nRRD	repeat	Sub-L	_oop ´	I, but	BA[2	= [0:	7						
5	ЧĜ	9	nFAW+4*nRRD	D	1	0	0	0	0	7	00	0	0	F	0	-
toggling	Static High			Assert		epeat	abov	e D Co				nFAW	/ - 1,	if nece	-	
ogo	atic		2*nFAW+0	ACT	0	0	1	1	0	0	00	0	0	F	0	-
-	St	10	2*nFAW+1	RDA	0	1	0	1	0	0	00	1	0	F	0	00110011
		10	2&nFAW+2	D	1	0	0	0	0	0	00	0	0	F	0	-
				Repeat			omm	and u	ntil 2*	f nFAV	r	RRD -	1			
			2*nFAW+nRRD	ACT	0	0	1	1	0	1	00	0	0	0	0	-
		11	2*nFAW+nRRD+1	RDA	0	1	0	1	0	1	00	1	0	0	0	00000000
			2&nFAW+nRRD+	D	1	0	0	0	0	1	00	0	0	0	0	-
			2	Repeat							V + 2	* nRR	2D - 1			
		12	2*nFAW+2*nRRD	repeat		•		-	-							
		13	2*nFAW+3*nRRD	repeat						-		1	1	1	1	
		14	2*nFAW+4*nRRD	D Assert	1 and r	0 onoat	0 abov		0	3	00 til 2*	0 nEA\A	0	0 if poce	0	-
		15	3*nFAW	repeat		•					itii J	III AM	v = 1,		-35ai y	
		16	3*nFAW+nRRD	repeat												
		10	3*nFAW+2*nRRD	repeat												
		17	3*nFAW+3*nRRD													
		19 3*nFAW + 4*nRRD														
			Assert and repeat above D Command until 4* nFAW - 1, if necessary													

a) DM must be driven LOW all the time. DQS, DQS are used according to RD Commands, otherwise MID-LEVEL.

b) Burst Sequence driven on each DQ signal by Read Command. Outside burst operation, DQ signals are MID-LEVEL.



#### **IDD Specifications**

IDD values are for full operating range of voltage and temperature unless otherwise noted.

#### **IDD** Specification

Speed Grade Bin	DDR3L - 1066 7-7-7	DDR3 L- 1333 9-9-9	DDR3L - 1600 11-11-11	DDR3L - 1866 13-13-13	Unit	Notes
Symbol	Max.	Max.	Max.	Max.		
1	28	28	28	32	mA	x8
/ <sub>DD0</sub>	33	33	35	36	mA	x16
1	32	32	32	36	mA	x8
/ <sub>DD01</sub>	41	41	45	45	mA	x16
1	11	11	11	11	mA	x8
<b>/</b> <sub>DD2P0</sub>	11	11	11	11	mA	x16
,	11	11	11	11	mA	x8
<b>/</b> <sub>DD2P1</sub>	14	14	14	14	mA	x16
1	13	14	14	16	mA	x8
/ <sub>DD2N</sub>	14	14	14	16	mA	x16
,	15	16	18	19	mA	x8
/ <sub>DD2NT</sub>	16	16	18	19	mA	x16
,	14	14	16	16	mA	x8
I <sub>DD2Q</sub>	16	16	16	16	mA	x16
,	19	19	19	20	mA	x8
/ <sub>DD3P</sub>	23	24	24	25	mA	x16
,	23	24	25	26	mA	x8
/ <sub>DD3N</sub>	29	31	32	33	mA	x16
,	50	63	69	82	mA	x8
/ <sub>DD4R</sub>	90	100	110	125	mA	x16
,	54	68	74	87	mA	x8
/ <sub>DD4w</sub>	95	105	115	130	mA	x16
,	143	143	146	146	mA	x8
I <sub>DD5</sub>	150	150	155	155	mA	x16
1	9	9	9	9	mA	x8
<b>/</b> <sub>DD6</sub>	9	9	9	9	mA	x16
I <sub>DD6 (</sub> Low Power)	6	6	6	6	mA	x8/16
•	11	11	11	11	mA	x8
I <sub>DD6ET</sub>	11	11	11	11	mA	x16
1	104	114	115	130	mA	x8
I <sub>DD7</sub>	180	180	185	189	mA	x16

#### Notes:

1. Applicable for MR2 settings A6=0 and A7=0. Temperature range for IDD6 is 0 -  $85^{\circ}$ C.

2. Applicable for MR2 settings A6=0 and A7=1. Temperature range for IDD6ET is 0 -  $95^{\circ}$ C.



# Input/Output Capacitance

Parameter	Symbol	DDR3L	-1066	DDR3I	L-1333	DDR3I	-1600	DDR3	L-1866	Units	Notes
Parameter	Symbol	Min	Max	Min	Мах	Min	Мах	Min	Мах	Units	Notes
Input/output ca <u>pacitance</u> (DQ, DM, DQS, DQS, TDQS, TDQS)	C <sub>IO</sub>	1.4	2.7	1.4	2.5	1.4	2.3	1.4	2.2	pF	1,2,3
Input capacitance, CK and CK	С <sub>СК</sub>	0.8	1.6	0.8	1.4	0.8	1.4	0.8	1.3	pF	2,3
Input ca <u>pa</u> citance delta CK and CK	C <sub>DCK</sub>	0	0.15	0	0.15	0	0.15	0	0.15	pF	2,3,4
Input cap <u>acita</u> nce delta, DQS and DQS	C <sub>DDQS</sub>	0	0.20	0	0.15	0	0.15	0	0.15	pF	2,3,5
Input capacitance (All other input-only pins)	CI	0.75	1.35	0.75	1.3	0.75	1.3	0.75	1.2	pF	2,3,6
Input capacitance delta (All CTRL input-only pins)	C <sub>DI_CTRL</sub>	-0.5	0.3	-0.4	0.2	-0.4	0.2	-0.4	0.2	pF	2,3,7,8
Input capacitance delta (All ADD/CMD input-only pins)	C <sub>DI_ADD_</sub> CMD	-0.5	0.5	-0.4	0.4	-0.4	0.4	-0.4	0.4	pF	2,3,9,10
Input/output capacitance delta (DQ, DM, DQS, DQS)	C <sub>DIO</sub>	-0.5	0.3	-0.5	0.3	-0.5	0.3	-0.5	0.3	pF	2,3,11
Input/output capacitance of ZQ pin	CZQ	-	3	-	3	-	3	-	3	pF	2,3,12

Notes:

1. Although the DM, TDQS and TDQS pins have different functions, the loading matches DQ and DQS.

- This parameter is not subject to production test. It is verified by design and characterization. The capacitance is measured according to JEP147("PROCEDURE FOR MEASURING INPUT CAPACITANCE USING A VECTOR NETWORK ANALYZER(VNA)") with VDD, VDDQ, VSS,VSSQ applied and all other pins floating (except the pin under test, CKE, RESET and ODT as necessary). VDD=VDDQ=1.5V, VBIAS=VDD/2 and on-die termination off.
- 3. This parameter applies to monolithic devices only; stacked/dual-die devices are not covered here
- 4. Absolute value of  $C_{CK}$ - $C_{\overline{CK}}$ .
- 5. Absolute value of  $C_{IO}(DQS)-C_{IO}(\overline{DQS})$ .
- 6. C<sub>1</sub> applies to ODT, CS, CKE, A0-A15, BA0-BA2, RAS, CAS, WE.
- 7.  $C_{DI \ CTR}$  applies to ODT,  $\overline{CS}$  and CKE.
- 8.  $C_{DI\_CTRL}=C_1(CNTL) 0.5 * C_1(CLK) + C_1(\overline{CLK}))$
- 9. C<sub>DI ADD CMD</sub> applies to A0-A15, BA0-BA2,  $\overline{RAS}$ ,  $\overline{CAS}$  and  $\overline{WE}$ .
- 10.  $C_{DI\_ADD\_CMD} = C_{I}(ADD\_CMD) 0.5*(C_{I}(CLK) + C_{I}(\overline{CLK}))$
- 11.  $C_{DIO} = C_{IO}(DQ) 0.5*(C_{IO}(DQS) + C_{IO}(\overline{DQS}))$
- 12. Maximum external load capacitance an ZQ pin: 5 pF.



# **Standard Speed Bins**

DDR3L SDRAM Standard Speed Bins include tCK, tRCD, tRP, tRAS and tRC for each corresponding bin.

#### DDR3L-1066 Speed Bins

	Speed Bin		DDR3L	1066		
C	L - nRCD - nR	Р	7-7	7-7	Unit	Note
Par	rameter	Symbol	min	max		
	ad command to st data	t <sub>AA</sub>	13.125	20	ns	
	iternal read or delay time	t <sub>RCD</sub>	13.125	_	ns	
PRE con	nmand period	t <sub>RP</sub>	13.125	_	ns	
	ACT or REF and period	t <sub>RC</sub>	50.625	_	ns	
	PRE command period	t <sub>RAS</sub>	37.5	9 * tREFI	ns	
CL = 5	CWL = 5	t <sub>CK(AVG)</sub>	3.0	3.3	ns	1, 2, 3, 4, 6, 12,13
02 0	CWL = 6	t <sub>CK(AVG)</sub>	Rese	erved	ns	4
CL = 6	CWL = 5	t <sub>CK(AVG)</sub>	2.5	3.3	ns	1, 2, 3, 6
CL = 0	CWL = 6	t <sub>CK(AVG)</sub>	Rese	erved	ns	1, 2, 3, 4
CL = 7	CWL = 5	t <sub>CK(AVG)</sub>	Rese	erved	ns	4
CL = 7	CWL = 6	t <sub>CK(AVG)</sub>	1.875	< 2.5	ns	1, 2, 3, 4
CL = 8	CWL = 5	t <sub>CK(AVG)</sub>	Rese	erved	ns	4
UL = 8	CWL = 6	t <sub>CK(AVG)</sub>	1.875	< 2.5	ns	1, 2, 3
Su	oported CL Setti	ngs	5, 6,	, 7, 8	n <sub>CK</sub>	13
Sup	ported CWL Set	tings	5,	6	n <sub>CK</sub>	



# DDR3L-1333 Speed Bins

	Speed Bin		Γ	DDR3L-1333		
С	L - nRCD - n	RP		9-9-9	Unit	Note
	ameter	Symbol	min	max		
	rnal read d to first data	t <sub>AA</sub>	13.5 (13.125) <sup>5,11</sup>	20	ns	
	ternal read or delay time	t <sub>RCD</sub>	13.5 (13.125) <sup>5,11</sup>	_	ns	
PRE com	mand period	t <sub>RP</sub>	13.5 (13.125) <sup>5,11</sup>	_	ns	
	ACT or REF and period	t <sub>RC</sub>	49.5 (49.125) <sup>5,11</sup>	_	ns	
	RE command period	t <sub>RAS</sub>	36	9 * tREFI	ns	
CL = 5	CWL = 5	t <sub>CK(AVG)</sub>	3.0	3.3	ns	1, 2, 3, 4, 7, 12,13
02 - 0	CWL = 6, 7	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 5	t <sub>CK(AVG)</sub>	2.5	3.3	ns	1, 2, 3, 7
CL = 6	CWL = 6	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4, 7
	CWL = 7	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 5	t <sub>CK(AVG)</sub>		Reserved	ns	4
CL = 7	CWL = 6	<i>t</i>	1.875	< 2.5	20	1 2 2 4 7
CL = 7	CVVL = 0	t <sub>CK(AVG)</sub>		(Optional) <sup>5</sup>	ns	1, 2, 3, 4, 7
	CWL = 7	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4
	CWL = 5	t <sub>CK(AVG)</sub>		Reserved	ns	4
CL = 8	CWL = 6	t <sub>CK(AVG)</sub>	1.875	< 2.5	ns	1, 2, 3, 7
	CWL = 7	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4
CL = 9	CWL = 5, 6	t <sub>CK(AVG)</sub>		Reserved	ns	4
CL = 9	CWL = 7	t <sub>CK(AVG)</sub>	1.5	<1.875	ns	1, 2, 3, 4
	CWL = 5, 6	t <sub>CK(AVG)</sub>		Reserved	ns	4
CL = 10	CWL = 7	t <sub>CK(AVG)</sub>	1.5	<1.875	ns	1, 2, 3
				(Optional)	ns	5
	ported CL Set	•	5, 6	6, 8, (7), 9, (10)	n <sub>CK</sub>	
Supp	oorted CWL Se	ettings		5, 6, 7	n <sub>CK</sub>	



### DDR3L-1600 Speed Bins

	Speed Bin		C	DR3L-1600		
С	L - nRCD - n	RP		11-11-11	Unit	Note
Par	ameter	Symbol	min	max		
	rnal read d to first data	t <sub>AA</sub>	13.75 (13.125) <sup>5,11</sup>	20	ns	
	ternal read or delay time	t <sub>RCD</sub>	13.75 (13.125) <sup>5,11</sup>	_	ns	
PRE com	mand period	t <sub>RP</sub>	13.75 (13.125) <sup>5,11</sup>	_	ns	
	ACT or REF and period	t <sub>RC</sub>	48.75 (48.125) <sup>5,11</sup>	_	ns	
	RE command period	t <sub>RAS</sub>	35	9 * tREFI	ns	
CL = 5	CWL = 5	t <sub>CK(AVG)</sub>	3.0	3.3	ns	1, 2, 3, 4, 8, 12,13
	CWL = 6, 7	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 5	t <sub>CK(AVG)</sub>	2.5	3.3	ns	1, 2, 3, 8
CL = 6	CWL = 6	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4, 8
	CWL = 7	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 5	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 6	t <sub>CK(AVG)</sub>	1.875	< 2.5	ns	1, 2, 3, 4, 8
CL = 7		·CK(AVG)		(Optional) <sup>5</sup>	113	
	CWL = 7	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4, 8
	CWL = 8	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 5	t <sub>CK(AVG)</sub>		Reserved	ns	4
CL = 8	CWL = 6	t <sub>CK(AVG)</sub>	1.875	< 2.5	ns	1, 2, 3, 8
02 - 0	CWL = 7	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4, 8
	CWL = 8	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4
	CWL = 5, 6	t <sub>CK(AVG)</sub>		Reserved	ns	4
CL = 9	CWL = 7	t <sub>CK(AVG)</sub>	1.5	<1.875	ns	1, 2, 3, 4, 8
02 /				(Optional) <sup>5</sup>	115	
	CWL = 8	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4
	CWL = 5, 6	t <sub>CK(AVG)</sub>		Reserved	ns	4
CL = 10		t <sub>CK(AVG)</sub>	1.5	<1.875	ns	1, 2, 3, 8
	CWL = 8	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4
CL = 11	CWL = 5, 6, 7	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 8	t <sub>CK(AVG)</sub>	1.25	<1.5	ns	1, 2, 3
Sup	ported CL Set	tings	5, 6,	(7), 8, (9), 10, 11	n <sub>CK</sub>	
Supp	orted CWL Se	ttings		5, 6, 7, 8	n <sub>CK</sub>	



# DDR3L-1866 Speed Bins

	Speed Bin		C	DR3L-1866		
(	CL - nRCD - nR	P		13-13-13	Unit	Note
Pa	rameter	Symbol	min	max		
	read command first data	t <sub>AA</sub>	13.91 (13.125) <sup>5,14</sup>	20	ns	
	nternal read or delay time	t <sub>RCD</sub>	13.91 (13.125) <sup>5,14</sup>	_	ns	
	mmand period	t <sub>RP</sub>	13.91 (13.125) <sup>5,14</sup>	_	ns	
	PRE command period	t <sub>RAS</sub>	34	9 * tREFI	ns	
	ACT or PRE nand period	t <sub>RC</sub>	47.91 (47.125) <sup>5,14</sup>	-	ns	
CL = 5	CWL = 5	t <sub>CK(AVG)</sub>	3.0	3.3	ns	1, 2, 3, 4, 9
GL = 0	CWL = 6,7,8,9	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 5	t <sub>CK(AVG)</sub>	2.5	3.3	ns	1, 2, 3, 9
CL = 6	CWL = 6	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4, 9
	CWL = 7,8,9	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 5	t <sub>CK(AVG)</sub>		Reserved	ns	4
CL = 7	CWL = 6	t <sub>CK(AVG)</sub>	1.875	< 2.5	ns	1, 2, 3, 4, 9
	CWL = 7,8,9	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 5	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 6	t <sub>CK(AVG)</sub>	1.875	< 2.5	ns	1, 2, 3, 9
CL = 8	CWL = 7	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4, 9
	CWL = 8,9	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 5, 6	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 7	t <sub>CK(AVG)</sub>	1.5	<1.875	ns	1, 2, 3, 4, 9
CL = 9	CWL = 8	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4, 9
	CWL = 9	t <sub>CK(AVG)</sub>		Reserved	ns	4
	CWL = 5, 6	t <sub>CK(AVG)</sub>		Reserved	ns	4
CL = 10	CWL = 7	t <sub>CK(AVG)</sub>	1.5	<1.875	ns	1, 2, 3, 9
	CWL = 8	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4, 9
	CWL = 5, 6, 7	t <sub>CK(AVG)</sub>		Reserved	ns	4
CL = 11		t <sub>CK(AVG)</sub>	1.25	<1.5	ns	1, 2, 3, 4, 9
	CWL = 9	t <sub>CK(AVG)</sub>		Reserved	ns	1, 2, 3, 4
	CWL = 5, 6, 7, 8	t <sub>CK(AVG)</sub>		Reserved	ns	4
CL = 12	CWL = 9	t <sub>CK(AVG)</sub>		Reserved	ns	1,2,3,4
	CWL = 5, 6, 7, 8	t <sub>CK(AVG)</sub>		Reserved	ns	4
CL = 13	CWL = 9	t <sub>CK(AVG)</sub>	1.07	<1.25	ns	1, 2, 3
Su	pported CL Setti			0, 13, (7), (9), (11)	n <sub>CK</sub>	
	ported CWL Set	-		5, 6, 7, 8, 9	n <sub>CK</sub>	



#### Speed Bin Table Notes

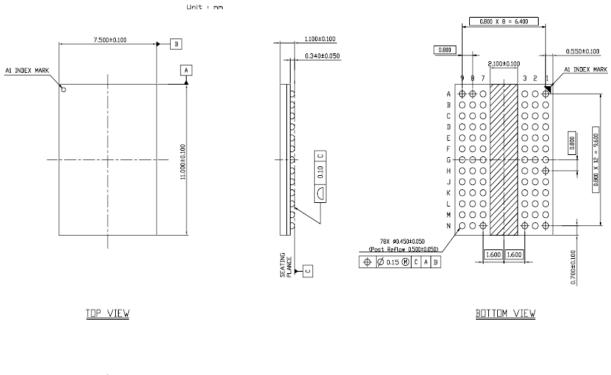
Absolute Specification ( $T_{OPER}$ ;  $V_{DDO} = V_{DD} = 1.5V + -0.075 V$ );

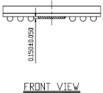
- 1. The CL setting and CWL setting result in tCK(AVG).MIN and tCK(AVG).MAX requirements. When making a selection of tCK(AVG), both need to be fulfilled: Requirements from CL setting as well as requirements from CWL setting.
- tCK(AVG).MIN limits: Since CAS Latency is not purely analog data and strobe output are synchronized by the DLL - all possible intermediate frequencies may not be guaranteed. An application should use the next smaller JEDEC standard tCK(AVG) value (3.0, 2.5, 1.875, 1.5, or 1.25 ns) when calculating CL [nCK] = tAA [ns] / tCK(AVG) [ns], rounding up to the next 'Supported CL', where tCK(AVG) = 3.0 ns should only be used for CL = 5 calculation.
- 3. tCK(AVG).MAX limits: Calculate tCK(AVG) = tAA.MAX / CL SELECTED and round the resulting tCK(AVG) down to the next valid speed bin (i.e. 3.3ns or 2.5ns or 1.875 ns or 1.25 ns). This result is tCK(AVG).MAX corresponding to CL SELECTED.
- 4. 'Reserved' settings are not allowed. User must program a different value.
- 5. 'Optional' settings allow certain devices in the industry to support this setting, however, it is not a mandatory feature. Refer to SK Hynix DIMM data sheet and/or the DIMM SPD information if and how this setting is supported.
- 6. Any DDR3L-1066 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.
- 7. Any DDR3L-1333 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.
- 8. Any DDR3L-1600 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.
- 9. Any DDR3L-1866 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.
- 10. Any DDR3L-2133 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.
- 11. SK Hynix DDR3L SDRAM devices supporting optional down binning to CL=7 and CL=9, and tAA/tRCD/ tRP must be 13.125 ns or lower. SPD settings must be programmed to match. For example, DDR3L-1333H devices supporting down binning to DDR3L-1066F should program 13.125 ns in SPD bytes for tAAmin (Byte 16), tRCDmin (Byte 18), and tRPmin (Byte 20). DDR3L-1600K devices supporting down binning to DDR3L-1333H or DDR3L-1600F should program 13.125 ns in SPD bytes for tAAmin (Byte 16), tRCDmin (Byte 18), and tRPmin (Byte 20). Once tRP (Byte 20) is programmed to 13.125ns, tRCmin (Byte 21,23) also should be programmed accordingly. For example, 49.125ns (tRASmin + tRPmin = 36 ns + 13.125 ns) for DDR3L-1333H and 48.125ns (tRASmin + tRPmin = 35 ns + 13.125 ns) for DDR3L-1600K.
- 12. DDR3L 800 AC timing apply if DRAM operates at lower than 800 MT/s data rate.
- 13. For CL5 support, refer to DIMM SPD information. DRAM is required to support CL5. CL5 is not mandatory in SPD coding.
- 14. SK Hynix DDR3L SDRAM devices supporting optional down binning to CL=11, CL=9 and CL=7, tAA/ tRCD/tRPmin must be 13.125ns. SPD setting must be programed to match. For example, DDR3L-1866M devices supporting down binning to DDR3L-1600K or DDR3L-1333H or 1066F should program 13.125ns in SPD bytes for tAAmin(byte 16), tRCDmin(byte 18) and tRPmin(byte 20) is programmed to 13.125ns, tRCmin(byte 21,23) also should be programmed accordingly. For example, 47.125ns (tRASmin + tRPmin = 34ns +13.125ns)



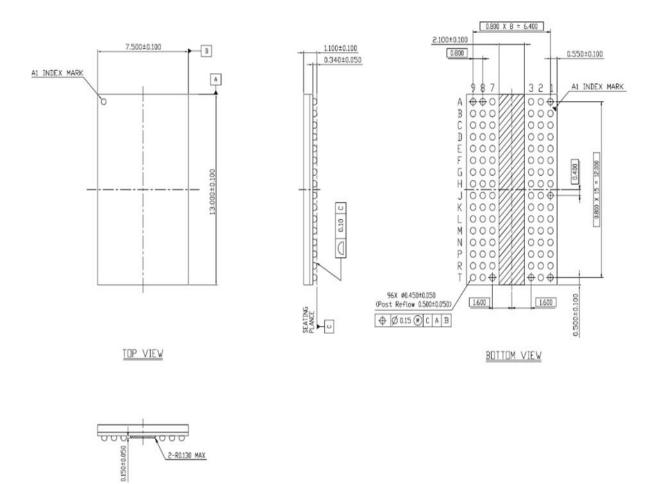
# **Package Dimensions**

Package Dimension(x8): 78Ball Fine Pitch Ball Grid Array Outline





#### Package Dimension(x16): 96Ball Fine Pitch Ball Grid Array Outline



FRONT VIEW